Pro Cuest

Databases selected: Multiple databases...

Terahertz all-optical modulation in a silicon-polymer hybrid system

Michael Hochberg, Tom Baehr-Jones, Guangxi Wang, Michael Shearn, et al. Nature Materials. London: Sep 2006. Vol. 5, Iss. 9; pg. 703

Subjects:	Materials science, Optics, Silicon, Polymers, Spectrum analysis
Author(s):	Michael Hochberg, Tom Baehr-Jones, Guangxi Wang, Michael Shearn, Katherine Harvard, Jingdong Luo, Baoquan Chen, Zhengwei Shi, Rhys Lawson, Phil Sullivan, Alex K. Y. Jen, Larry Dalton, Axel Scherer
Document types:	Feature
Publication title:	Nature Materials. London: Sep 2006. Vol. 5, Iss. 9; pg. 703
Source type:	Periodical
ISSN:	14761122
ProQuest document ID:	1118036571
Text Word Count	5050
DOI:	10.1038/nmat1719
Document URL:	http://proquest.umi.com/pqdweb?did=1118036571&sid=1&Fmt=2&cl ientId=8991&RQT=309&VName=PQD

Abstract (Document Summary)

Although gigahertz-scale free-carrier modulators have been demonstrated in silicon, intensity modulators operating at terahertz speeds have not been reported because of silicon's weak ultrafast nonlinearity. We have demonstrated intensity modulation of light with light in a silicon-polymer waveguide device, based on the all-optical Kerr effect--the ultrafast effect used in four-wave mixing. Direct measurements of time-domain intensity modulation are made at speeds of 10 GHz. We showed experimentally that the mechanism of this modulation is ultrafast through spectral measurements, and that intensity modulation at frequencies in excess of 1 THz can be obtained. By integrating optical polymers through evanescent coupling to silicon waveguides, we greatly increase the effective nonlinearity of the waveguide, allowing operation at continuous-wave power levels compatible with telecommunication systems. These devices are a first step in the development of large-scale integrated ultrafast optical logic in silicon, and are two orders of magnitude faster than previously reported silicon devices. [PUBLICATION ABSTRACT]

Copyright © 2007 ProQuest-CSA LLC. All rights reserved.



